## (19) World Intellectual Property Organization

International Bureau





(43) International Publication Date 16 June 2005 (16.06.2005)

PCT

## (10) International Publication Number WO 2005/053373 A2

Not classified (51) International Patent Classification:

(21) International Application Number:

PCT/IB2004/004394

(22) International Filing Date: 2 December 2004 (02.12.2004)

(25) Filing Language:

English

(26) Publication Language:

English

(30) Priority Data:

60/526,082

2 December 2003 (02.12.2003)

(71) Applicant (for all designated States except US): UNITED TEST AND ASSEMBLY CENTER [SG/SG]; 5 Serangoon North Avenue 5, 554916 Singapore (SG).

(72) Inventors; and

(75) Inventors/Applicants (for US only): TAN, Hien Boon [MY/SG]; Blk 61, Choa Chu Kang Loop #12-01, 689668 Singapore (SG). WANG, Chuen Khiang [SG/SG]; Blk 315C Anchorvale Road #09-180, 543315 Singapore (SG). BIDIN, Rahamat [SG/SG]; 10A Jalan Ulu Siglap, 457135 Singapore (SG). SUN, Anthony Yi Sheng [CN/SG]; 19 Fort Road #07-04, 439088 Singapore (SG). CHONG, Desmond Yok Rue [SG/SG]; Blk 423 Fajar Road #02-523, 670423 Singapore (SG). KOLAN, Ravi Kanth [IN/SG]; Blk 153, Serangoon North Ave 1, #04-526, 550153 Singapore (SG).

- (81) Designated States (unless otherwise indicated, for every kind of national protection available): AE, AG, AL, AM, AT, AU, AZ, BA, BB, BG, BR, BW, BY, BZ, CA, CH, CN, CO, CR, CU, CZ, DE, DK, DM, DZ, EC, EE, EG, ES, FI, GB, GD, GE, GH, GM, HR, HU, ID, IL, IN, IS, JP, KE, KG, KP, KR, KZ, LC, LK, LR, LS, LT, LU, LV, MA, MD, MG, MK, MN, MW, MX, MZ, NA, NI, NO, NZ, OM, PG, PH, PL, PT, RO, RU, SC, SD, SE, SG, SK, SL, SY, TJ, TM, TN, TR, TT, TZ, UA, UG, US, UZ, VC, VN, YU, ZA, ZM, ZW.
- (84) Designated States (unless otherwise indicated, for every kind of regional protection available): ARIPO (BW, GH, GM, KE, LS, MW, MZ, NA, SD, SL, SZ, TZ, UG, ZM, ZW), Eurasian (AM, AZ, BY, KG, KZ, MD, RU, TJ, TM), European (AT, BE, BG, CH, CY, CZ, DE, DK, EE, ES, FI, FR, GB, GR, HU, IE, IS, IT, LT, LU, MC, NL, PL, PT, RO, SE, SI, SK, TR), OAPI (BF, BJ, CF, CG, CI, CM, GA, GN, GQ, GW, ML, MR, NE, SN, TD, TG).

## Published:

without international search report and to be republished upon receipt of that report

For two-letter codes and other abbreviations, refer to the "Guidance Notes on Codes and Abbreviations" appearing at the beginning of each regular issue of the PCT Gazette.

(54) Title: CHIP SCALE PACKAGE AND METHOD OF ASSEMBLING THE SAME

(57) Abstract: A method of producing a chip scale package is disclosed. The method includes dicing a wafer into a plurality of chip arrays, each array including two or more integrated circuit chips. The method further includes mounting each array on a substrate and dicing each array, attached to the substrate, into individual chip scale packages, each individual chip scale package including only one integrated circuit chip.